Power Analysis Part V: DPA Cont'd Cryptographic Hardware for Embedded Systems ECE 3170

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Reading

• This lecture covers a portion of Differential Power Analysis as explained in Chapter 6 of *Power Analysis Attacks: Revealing the Secrets of Smart Cards* by Mangard et al., 2007, ISBN-13: 978-0-387-30857-9, ISBN-10: 0-387-30857-1, e-ISBN-10: 0-387-38162-7.

Questions Answered by This Lecture

- How can one carry out DPA on a microcontroller running AES with the goal of finding the key?
 - Assumption # 1: the attacker can input any plaintext desired and obtain the corresponding ciphertext
 - Assumption # 2: the attacker can accurately measure power (either through physical access or remote access to the power trace data measurement)

Steps in Differential Power Analysis

- 1. Choose an intermediate part of the algorithm to attack
 - a. For example, function f(d,k) where d is a data input and k is a small part of the secret key stored in the device under attack
 - b. Typically *d* is either plaintext or ciphertext
- 2. Make a large number of power measurements
 - a. Keep track of the known data values d_i as recording the measurements
 - b. For each d_i there exists a power trace of size T: $t'_i = (t_{i,1}, ..., t_{i,T})$
- 3. Calculate hypothetical intermediate values
 - a. For each k, the K possible choices are $\mathbf{k} = (k_1, ..., k_K)$
 - b. The possible choices are used in conjunction with f(d,k)
- Map hypothetical intermediate values to resulting predicted power values
- 5. Compare predicted power values with the actual trace values

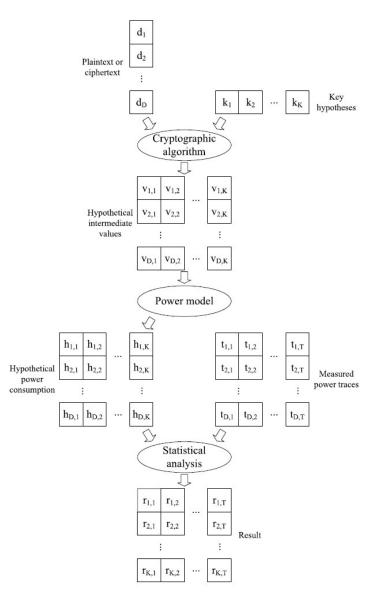
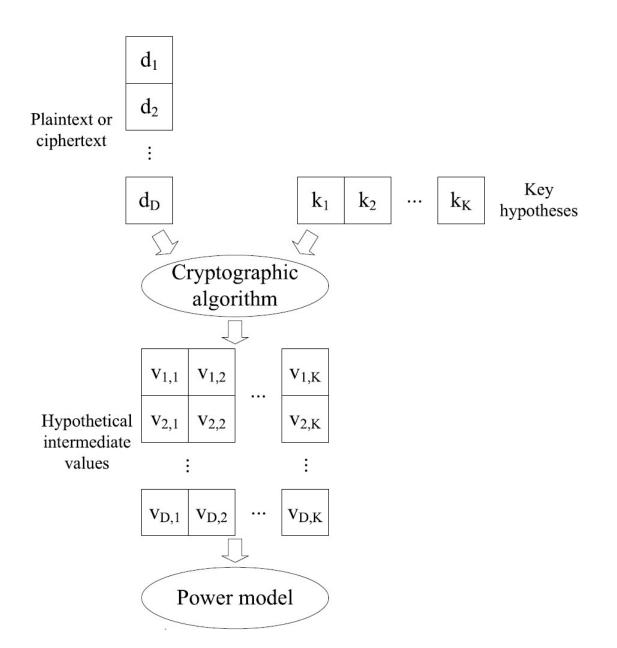
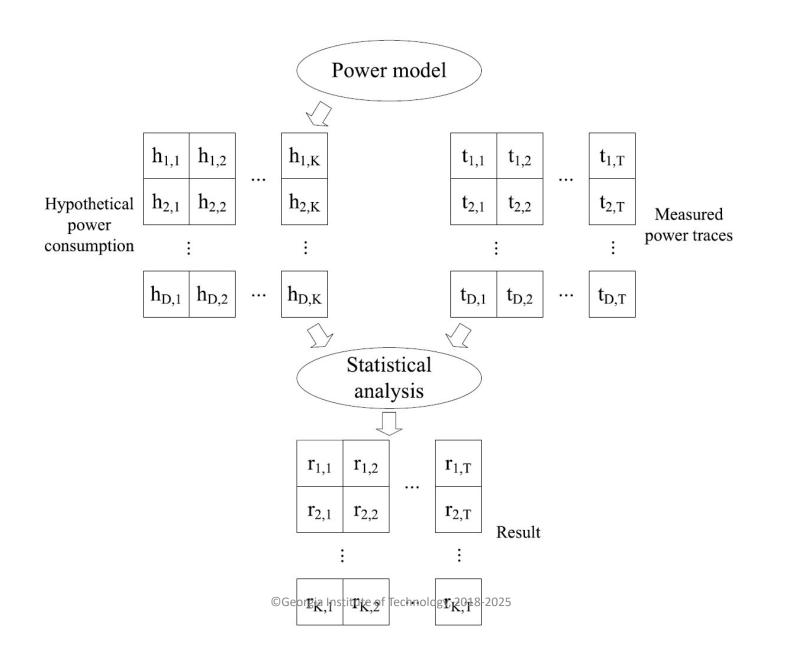


Figure 6.1. Block diagram illustrating the steps 3 to 5 of a DPA attack.

Microcontroller Example

- AES software SBOX calculation
 - s = S(p XOR k) where p is the plaintext and k is the subkey (each of size 8 bits)
- Calculate 1000 power traces
 - Each power trace corresponds to a specific plaintext input
 - Hence, there are 1000 power measurements taken for each value of the 128 bit plaintext
 - Note that the overall plaintext input size is 128 for AES, hence there are 2¹²⁸ possible values of the overall plaintext
 - E.g., for a timeframe of 100 μ s, there is a measurement for every 100 ns (10 MHz sample rate of the power measurement device, e.g., an oscilloscope)
 - A total of 1,000,000 measurements are stored in this example, e.g., from an oscilloscope based power measurement setup
 - If each measurement requires 32 bits (a word), then the filesize is 4 MB (Megabytes)





Microcontroller Example Continued

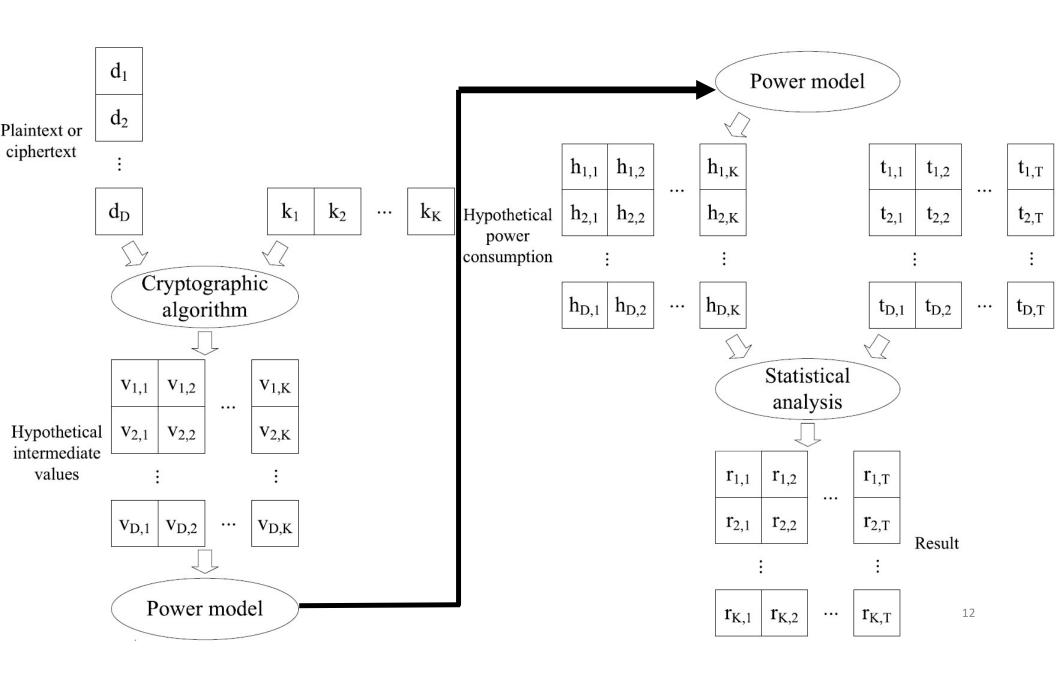
- AES software SBOX calculation
 - Let us consider the first byte (8 bits) of the overall plaintext input (128 bits)
 - s = S(p XOR k) where p is the plaintext and k is the subkey (each of size 8 bits)
- Recall we have 1000 power traces, each with a known specific value of p

Steps in Differential Power Analysis

- 1. Choose an intermediate part of the algorithm to attack
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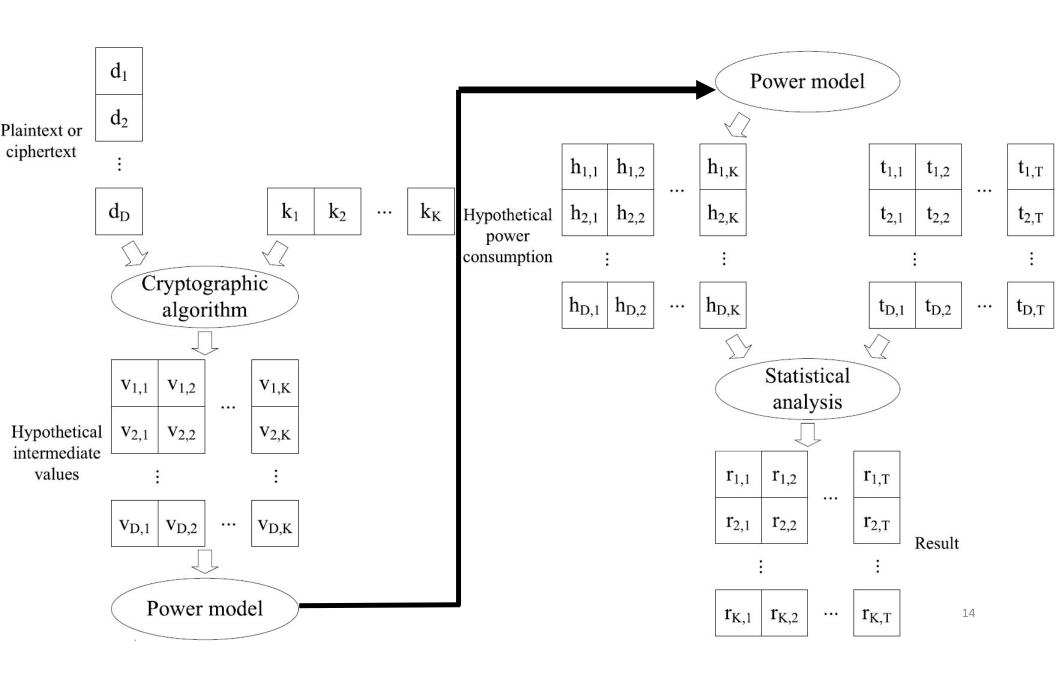
Microcontroller Example Continued

- AES software SBOX calculation
 - Let us consider the first byte (8 bits) of the overall plaintext input (128 bits)
 - s = S(p XOR k) where p is the plaintext and k is the subkey (each of size 8 bits)
- Recall we have 1000 power traces, each with a known specific value of p
- Step 3 is to calculate hypothesized intermediate values of s = S(p XOR k)
 - Let $v_{i,j} = s_{i,j} = S(p_i XOR k_i)$ where i ranges from 1 to 1000 and j from 0 to 256
 - Matrix $\mathbf{V} = \{v_{i,j}\}$ has size 1000 rows by 256 columns



Microcontroller Example Continued Again

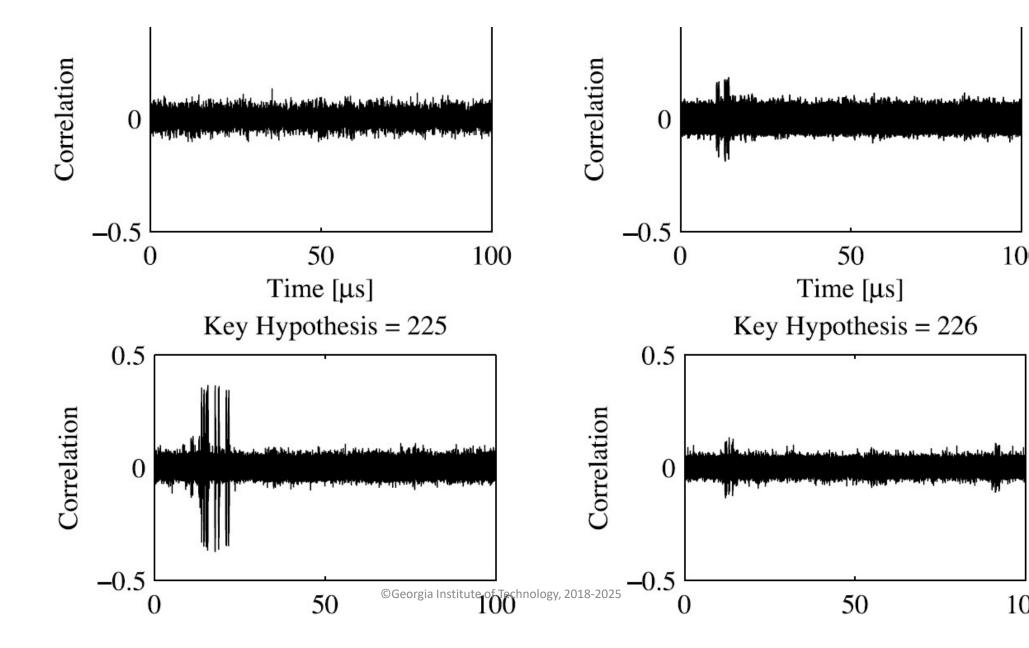
- AES software SBOX calculation s = S(p XOR k)
- We have 1000 power traces each with a known specific value of p
- Step 3 is has calculated hypothesized intermediate values
 - $V = \{v_{i,i}\} = \{s_{i,i}\} = \{s(p_i XOR k_i)\}$ of size 1000 rows by 256 columns
- Step 4 in this example maps V to H
 - Use $h_{i,j} = LSB(v_{i,j}) = LSB(s_{i,j}) = LSB(S(p_i XOR k_i))$
 - $\mathbf{H} = \{h_{i,j}\}$ = results of an energy consumption model = an estimated set of power measurements based on a power model and assumed key values = a vector of size 1000 rows by 256 columns



Microcontroller Example Continued Again

- AES software SBOX calculation s = S(p XOR k)
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- Step 4 in this example maps V to H
 - Use $h_{i,j} = LSB(v_{i,j}) = LSB(s_{i,j}) = LSB(S(p_j XOR k_j))$
 - $\mathbf{H} = \{h_{i,j}\}$ = results of an energy consumption model = an estimated set of power measurements based on a power model and assumed key values = a vector of size 1000 rows by 256 columns
- Step 5 is to calculate the covariance of H with the actual trace data

$$r_{i,j} = \frac{\sum_{d=1}^{D} (h_{d,i} - \bar{h}_i) \cdot (t_{d,j} - \bar{t}_j)}{\sqrt{\sum_{d=1}^{D} (h_{d,i} - \bar{h}_i)^2 \cdot \sum_{d=1}^{D} (t_{d,j} - \bar{t}_j)^2}}$$
(6.2)



Comments

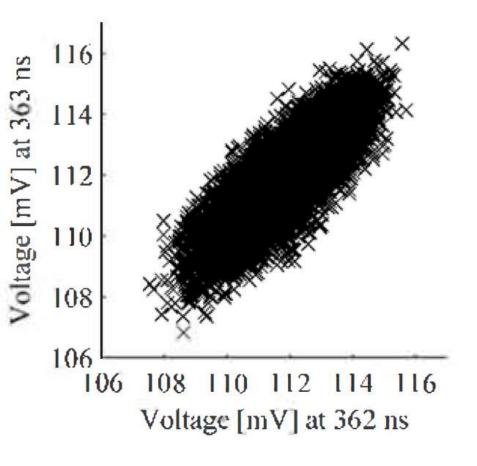
Correlation and Covariance

- Two points are correlated if they vary together in a related way
- Statistical measure: covariance
- Cov(X,Y) = E[(X-E(X))*(Y-E(Y))] = E(XY) E(X)E(Y)
- Theoretical and empirical formulas:

•
$$\rho(X,Y) = \frac{Cov(X,Y)}{\sqrt{Var(X)*Var(Y)}}$$

•
$$\gamma = \frac{\sum_{i=1}^{n} (x_i - \overline{x_i}) * (y_i - \overline{y_i})}{\sqrt{\sum_{i=1}^{n} (x_i - \overline{x_i})^2 * \sum_{i=1}^{n} (y_i - \overline{y_i})^2}}$$

• As defined, the correlation coefficient ρ varies between -1 and 1, i.e., $-1 \le \rho \le 1$ and also thus $-1 \le r \le 1$



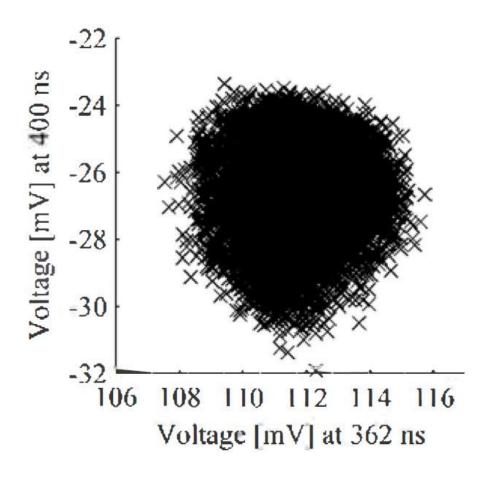


Figure 4.9. Scatter Plot: The power consumption at 362 ns is correlated to the power consumption at 363 ns. r = 0.82

ower conthe power sumption at 362 ns is largely uncorrelated to r = 0.82 the power consumption at 400 ns. r = 0.12©Georgia Institute of Technology, 2018-2025